

SILICON N-CHANNEL DUAL GATE MOS-FET

Depletion type field-effect transistor in a plastic X-package with source and substrate interconnected. Intended for UHF applications, such as UHF television tuners, with 12 V supply voltage and professional communication equipment.

This MOS-FET tetrode is protected against excessive input voltage surges by integrated back-to-back diodes between gates and source.

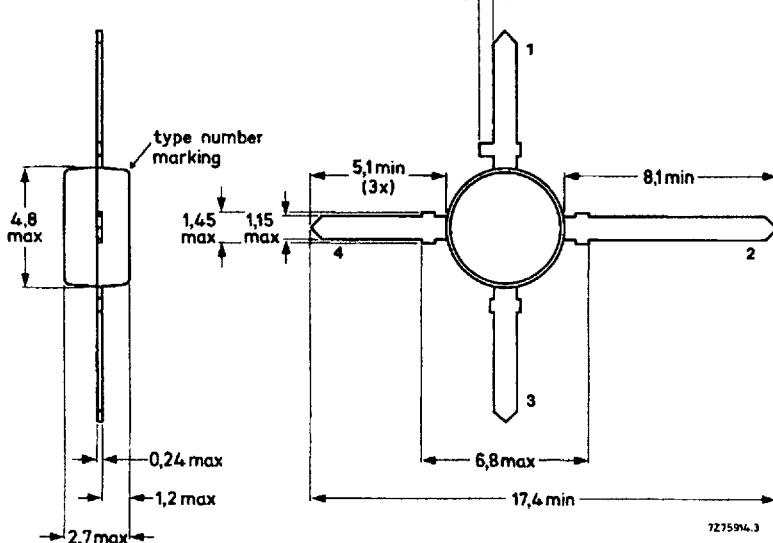
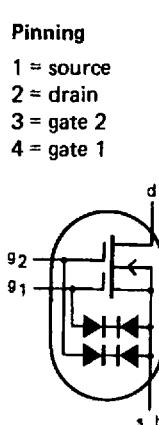
QUICK REFERENCE DATA

Drain-source voltage	V _{DS}	max.	18 V
Drain current (DC)	I _D	max.	30 mA
Total power dissipation up to T _{amb} = 75 °C	P _{tot}	max.	225 mW
Junction temperature	T _j	max.	150 °C
Transfer admittance at f = 1 kHz I _D = 10 mA; V _{DS} = 10 V; + V _{G2-S} = 4 V	Y _{fs}	typ.	19 mS
Input capacitance at gate 1; f = 1 MHz I _D = 10 mA; V _{DS} = 10 V; + V _{G2-S} = 4 V	C _{ig1-s}	typ.	2.6 pF
Feedback capacitance at f = 1 MHz I _D = 10 mA; V _{DS} = 10 V; + V _{G2-S} = 4 V	C _{rs}	typ.	25 fF
Noise figure at G _S = 5 mS; B _S = B _S opt I _D = 10 mA; V _{DS} = 10 V; + V _{G2-S} = 4 V; f = 800 MHz	F	typ.	2.0 dB

MECHANICAL DATA

Fig.1 SOT103.

Dimensions in mm



RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Drain-source voltage	V_{DS}	max.	18 V
Drain current (DC or average)	I_D	max.	30 mA
Gate 1 - source current	$\pm I_{G1-S}$	max.	10 mA
Gate 2 - source current	$\pm I_{G2-S}$	max.	10 mA
Total power dissipation up to $T_{amb} = 75^\circ\text{C}$	P_{tot}	max.	225 mW
Storage temperature range	T_{stg}	-65 to + 150	$^\circ\text{C}$
Junction temperature	T_j	max.	150 $^\circ\text{C}$

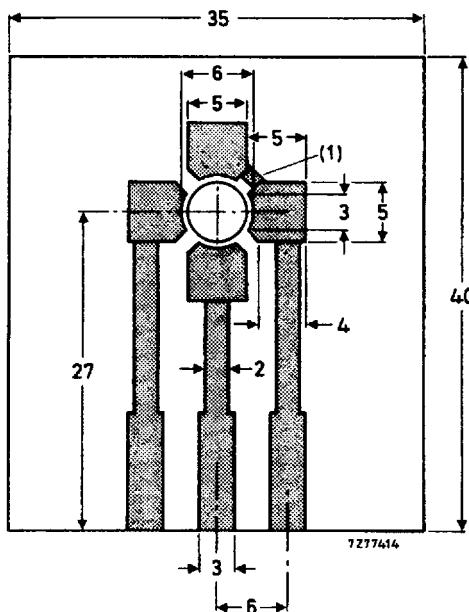
THERMAL RESISTANCE

From junction to ambient in free air

mounted on the printed-circuit board (see Fig.2)

$$R_{thj-a} = 335 \text{ K/W}$$

Dimensions in mm



(1) Connection made by a strip or Cu wire.

Fig.2 Single-sided 35 μm Cu-clad epoxy fibre-glass printed-circuit board, thickness 1.5 mm. Tracks are fully tin-lead plated. Board in horizontal position for R_{th} measurement.

STATIC CHARACTERISTICS $T_j = 25^\circ\text{C}$ unless otherwise specified**Gate cut-off currents**

$\pm V_{G1-S} = 7 \text{ V}; V_{G2-S} = V_{DS} = 0$	$\pm I_{G1-SS}$	max.	25 nA
$\pm V_{G2-S} = 7 \text{ V}; V_{G1-S} = V_{DS} = 0$	$\pm I_{G2-SS}$	max.	25 nA

Gate-source breakdown voltages

$\pm I_{G1-SS} = 10 \text{ mA}; V_{G2-S} = V_{DS} = 0$	$\pm V_{(BR)G1-SS}$	8 to 20	V
$\pm I_{G2-SS} = 10 \text{ mA}; V_{G1-S} = V_{DS} = 0$	$\pm V_{(BR)G2-SS}$	8 to 20	V

Gate-source cut-off voltages

$I_D = 20 \mu\text{A}; V_{DS} = 10 \text{ V}; + V_{G2-S} = 4 \text{ V}$	$-V_{(P)G1-S}$	min.	0.2 V
		max.	1.3 V
$I_D = 20 \mu\text{A}; V_{DS} = 10 \text{ V}; V_{G1-S} = 0$	$-V_{(P)G2-S}$	min.	0.2 V
		max.	1.1 V

DYNAMIC CHARACTERISTICSMeasuring conditions (common source): $I_D = 10 \text{ mA}; V_{DS} = 10 \text{ V}; + V_{G2-S} = 4 \text{ V}; T_{amb} = 25^\circ\text{C}$

Transfer admittance at $f = 1 \text{ kHz}$	$ y_{fs} $	min.	18 mS
		typ.	19 mS
Input capacitance at gate 1; $f = 1 \text{ MHz}$	C_{ig1-s}	typ.	2.6 pF
		max.	3.0 pF
Feedback capacitance at $f = 1 \text{ MHz}$	C_{rs}	typ.	25 fF
		max.	35 fF
Output capacitance at $f = 1 \text{ MHz}$	C_{os}	typ.	1.1 pF
Noise figure at $f = 800 \text{ MHz}; G_S = 5 \text{ mS}; B_S = B_S \text{ opt}$	F	typ.	2.0 dB
		max.	3.0 dB

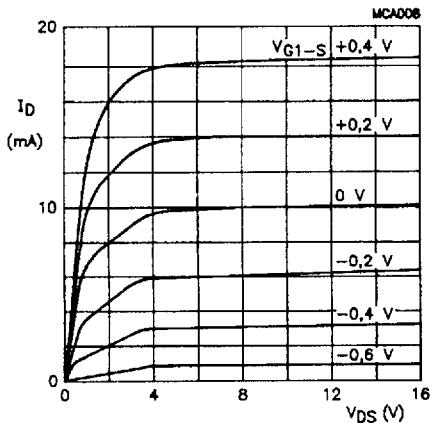


Fig.3 Output characteristics.
 $V_{G2-S} = 4$ V; $T_{amb} = 25$ °C.

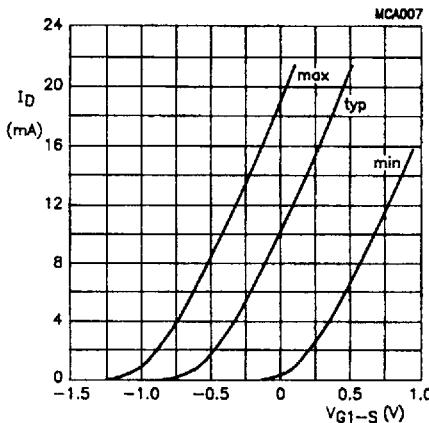


Fig.4 Transfer characteristics.
 $V_{DS} = 10$ V; $V_{G2-S} = 4$ V;
 $T_{amb} = 25$ °C.

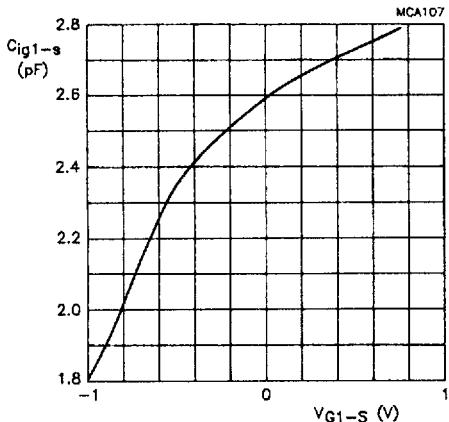


Fig.5 Gate 1 input capacitance as a function of gate 1 source voltage;
 $f = 1$ MHz; $V_{DS} = 10$ V; $V_{G2-S} = 4$ V;
 $T_{amb} = 25$ °C.

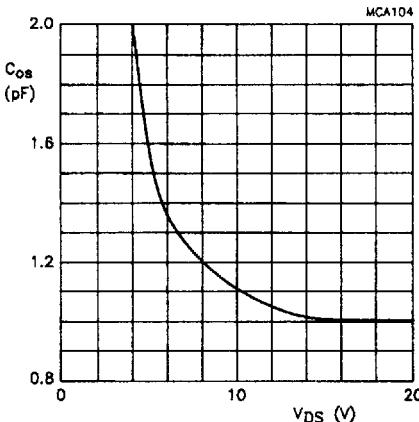


Fig.6 Output capacitance as a function of drain voltage; $f = 1$ MHz;
 $I_D = 10$ mA; $V_{G2-S} = 4$ V;
 $T_{amb} = 25$ °C.

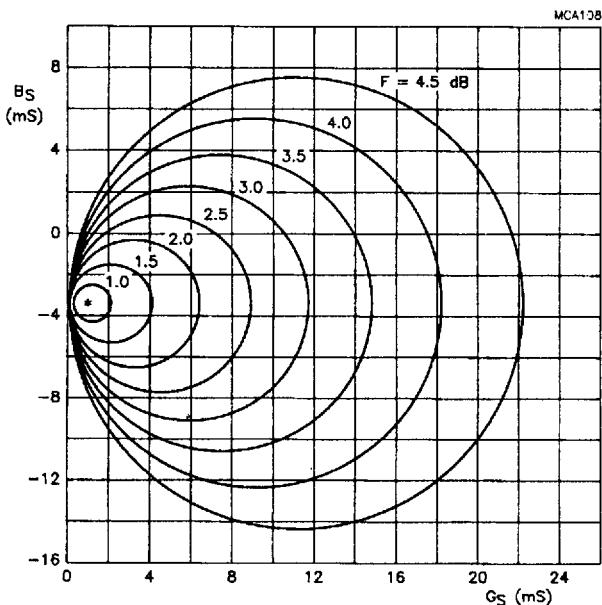


Fig.7 Circles of constant noise figures; $f = 200$ MHz;
 $T_{amb} = 25$ °C; $V_{DS} = 10$ V; $V_{G2-S} = 4$ V; $I_D = 10$ mA.

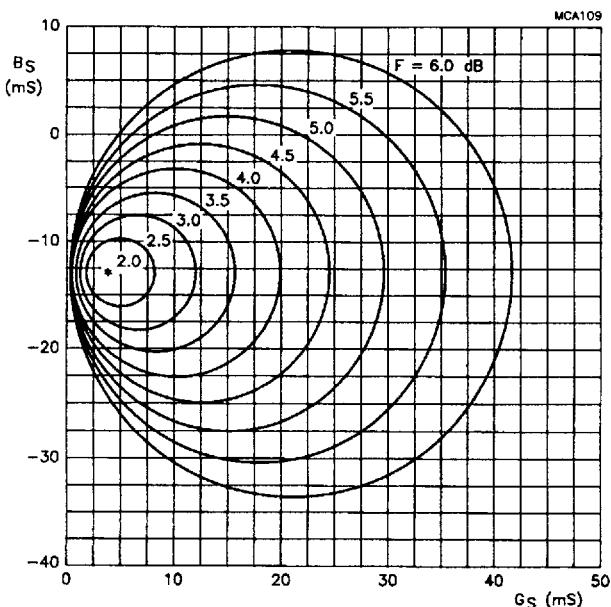


Fig.8 Circles of constant noise figures; $f = 800$ MHz;
 $T_{amb} = 25$ °C; $V_{DS} = 10$ V; $V_{G2-S} = 4$ V; $I_D = 10$ mA.

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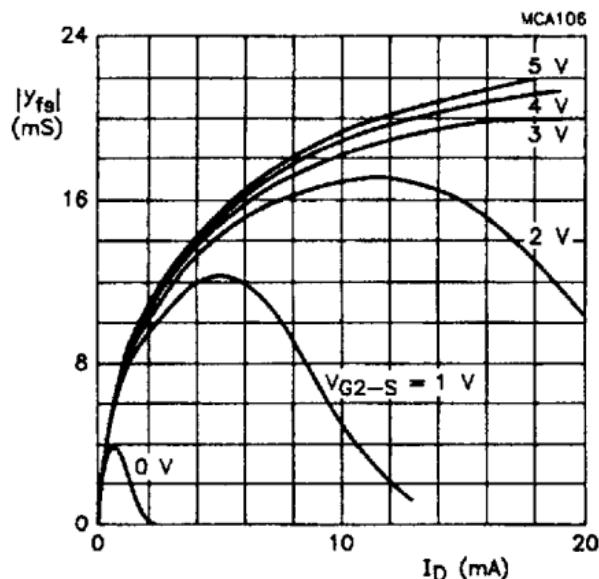


Fig.9 Forward transfer admittance as a function of drain current; $f = 1$ kHz;
 $V_{DS} = 10$ V; $T_{amb} = 25$ °C.

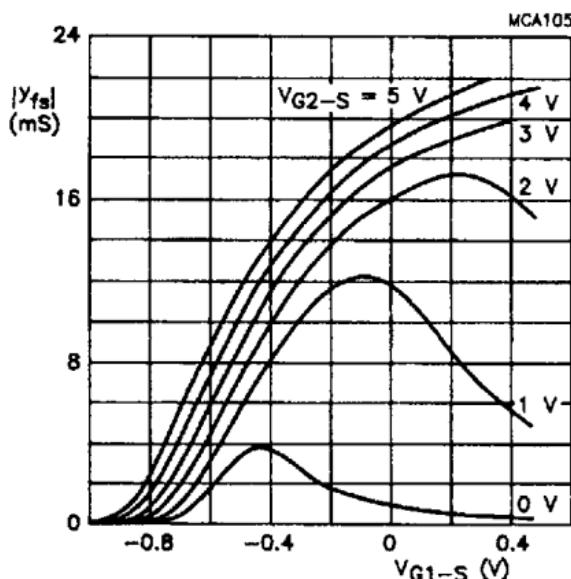


Fig.10 Forward transfer admittance as a function of gate 1 source voltage;
 $f = 1$ kHz; $V_{DS} = 10$ V; $T_{amb} = 25$ °C.